

Notice of References Cited

Application/Control No.

10/748,963

Applicant(s)/Patent Under
Reexamination
CHEN ET AL.

Examiner

Dylan White

Art Unit

2819

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,507,213	01-2003	Dangat, Harish	326/38
*	B	US-5,887,145	03-1999	Harari et al.	710/301
*	C	US-2005/0222300	10-2005	Ikezawa et al.	523/457
*	D	US-6,028,319	02-2000	Tsai, Yun T.	250/559.34
*	E	US-2003/0230799	12-2003	Yee et al.	257/706
*	F	US-6,759,870	07-2004	Cliff et al.	326/41
*	G	US-6,917,219	07-2005	New, Bernard J.	326/41
*	H	US-6,031,391	02-2000	Couts-Martin et al.	326/38
*	I	US-6,337,579	01-2002	Mochida, Hiroo	326/41
*	J	US-6,567,518	05-2003	Weir, Stephen	379/333
*	K	US-6,876,228	04-2005	Sunaga et al.	326/40
*	L	US-6,259,271	07-2001	Couts-Martin et al.	326/40
*	M	US-6,893,268	05-2005	Harari et al.	439/43

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.